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APPLICATION NO.	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.
10/033,854	12/19/2001	Mahesh Sambasivam	42390P13267	9103
8791	7590 08/21/2003			
BLAKELY SOKOLOFF TAYLOR & ZAFMAN			EXAMINER	
	HIRE BOULEVARD, SEVENTH FLOOR JES, CA 90025		NGUYEN, KHIEM D	
			ART UNIT	PAPER NUMBER
			2823	
			DATE MAILED: 08/21/2003	

Please find below and/or attached an Office communication concerning this application or proceeding.

	Application No.	Applicant(s)			
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	10/033,854	SAMBASIVAM ET AL.			
Office Action Summary	Examiner	Art Unit			
	Khiem D Nguyen	2823			
Th MAILING DATE of this communication apperiod for Reply	pears on the cov r she t with	the correspondenc address			
A SHORTENED STATUTORY PERIOD FOR REPL THE MAILING DATE OF THIS COMMUNICATION. - Extensions of time may be available under the provisions of 37 CFR 1.1 after SIX (6) MONTHS from the mailing date of this communication. - If the period for reply specified above is less than thirty (30) days, a repl - If NO period for reply is specified above, the maximum statutory period - Failure to reply within the set or extended period for reply will, by statute - Any reply received by the Office later than three months after the mailin earned patent term adjustment. See 37 CFR 1.704(b). Status	136(a). In no event, however, may a reply ly within the statutory minimum of thirty (3 will apply and will expire SIX (6) MONTHS e, cause the application to become ABAN	y be timely filed 10) days will be considered timely. S from the mailing date of this communication. DONED (35 U.S.C. § 133).			
1) Responsive to communication(s) filed on 02	June 2003 .				
· · · <u> </u>	nis action is non-final.				
3) Since this application is in condition for allow closed in accordance with the practice under					
Disposition of Claims 4) Claim(s) 1-20 is/are pending in the application	n				
4a) Of the above claim(s) is/are withdra					
5) Claim(s) is/are allowed.	WIT HOTH CONSIDERATION.				
6)⊠ Claim(s) <u>1-20</u> is/are rejected.					
7) Claim(s) is/are objected to.					
8) Claim(s) are subject to restriction and/o	or election requirement.				
Application Papers	1				
9)☐ The specification is objected to by the Examine	er.				
10)⊠ The drawing(s) filed on 19 December 2001 is/a	are: a)⊠ accepted or b)□ obje	cted to by the Examiner.			
Applicant may not request that any objection to the	• • • • • • • • • • • • • • • • • • • •	• • •			
11) The proposed drawing correction filed on	_ is: a)□ approved b)□ disa	approved by the Examiner.			
If approved, corrected drawings are required in re	•				
12) The oath or declaration is objected to by the Ex	xaminer.				
Priority under 35 U.S.C. §§ 119 and 120					
13) Acknowledgment is made of a claim for foreig	n priority under 35 U.S.C. § 1	119(a)-(d) or (f).			
a) ☐ All b) ☐ Some * c) ☐ None of:					
1. Certified copies of the priority documen	ts have been received.				
2. Certified copies of the priority documen	ts have been received in App	lication No			
3. Copies of the certified copies of the price application from the International But See the attached detailed Office action for a list	ureau (PCT Rule 17.2(a)).	_			
14)☐ Acknowledgment is made of a claim for domest	tic priority under 35 U.S.C. §	119(e) (to a provisional application).			
a) The translation of the foreign language pro	- •				
Attachment(s)					
1) Notice of References Cited (PTO-892) 2) Notice of Draftsperson's Patent Drawing Review (PTO-948) 3) Information Disclosure Statement(s) (PTO-1449) Paper No(s)	5) Notice of Info	mmary (PTO-413) Paper No(s) ormal Patent Application (PTO-152)			

U.S. Patent and Trademark Office PTO-326 (Rev. 04-01)

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DETAILED ACTION

In view of the arguments presented in the Appeal Brief filed June 2, 2003, paper No. 10, prosecution on the merits is reopened to address the issues raised in the Brief.

Upon the updated search on August 7, 2003, the newly found reference to Akram et al.

(U.S. Patent 5,766,982) is brought to the examiner's attention. The grounds of rejections in the prior Office actions are withdrawn, and new grounds of rejection base on the newly found reference are presented here. 37 CFR 1.193 (b)(2) applies:

- (2) Where prosecution is reopened by the primary examiner after an appeal or reply brief has been filed, appellant must exercise one of the following two options to avoid abandonment of the application:
- (i) File a reply under § 1.111, if the Office action is not final, or a reply under § 1.113, if the Office action is final; or
- (ii) Request reinstatement of the appeal. If reinstatement of the appeal is requested, such request must be accompanied by a supplemental appeal brief, but no new amendments, affidavits (§ § 1.130, 1.131 or 1.132) or other evidence are permitted.

Claim Rejections - 35 USC § 103

The following is a quotation of 35 U.S.C. 103(a) which forms the basis for all obviousness rejections set forth in this Office action:

(a) A patent may not be obtained though the invention is not identically disclosed or described as set forth in section 102 of this title, if the differences between the subject matter sought to be patented and the prior art are such that the subject matter as a whole would have been obvious at the time the invention was made to a person having ordinary skill in the art to which said subject matter pertains. Patentability shall not be negatived by the manner in which the invention was made.

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Claims 1-20 are rejected under 3 5 U.S. C. 103(a) as being unpatentable over Applicant's Admitted Prior Art (AAPA) in combination with Akram et al. (U.S. Patent No. 5,766,982) and Cha et al (U.S. Patent No. 6,242,798).

Applicant's admitted prior art discloses in figures 12-18 and related text of the specification a method of fabricating a microelectric package comprising providing a substrate (figure 12, 204) having a first surface (figure 12, 214), and opposing second surface, and a plurality of lands (figure 12, 212) disposed on the first surface; providing a microelectronic die (figure 12, 202) having an active surface (figure 12, 208), a back surface, and a plurality of pads (figure 12, 206) disposed on the active surface in a corresponding relationship to the plurality of substrate lands; electrically attaching the plurality of substrate lands to the plurality of corresponding microelectronic die pads with a plurality of conductive bumps (figure 12, 216); disposing an underfill material (figure 13, 222) such that the underfill material is dispersed between the microelectronic die active surface and the substrate first surface wherein the underfill material is dispensed by a needle (figure 13, 230) and the underfill material comprises an epoxy material (page 3, line 6) and is cured (page 3, line 10).

AAPA also discloses providing a second micorelectronic die (figure 17, 242) having an active surface (figure 17, 256), a back surface (figure 17, 244) and at least one wirebond pad (figure 17, 254) disposed on the active surface, attaching the second microelectronic die back surface to the microelectronic die back surface (figure 17) and attaching at least one wirebond (figure 17, 252) between the at least one substrate wirebond land (figure 17, 258) and the second microelectronic wirebond pad, wherein

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attaching the second microelectronic die back surface to the microelectronic die back surface comprises disposing a layer of adhesive therebetween (page 4, line 5).

AAPA fails to disclose forming a through hole extending from the substrate first surface to the substrate second surface and disposing the underfill material through the through hole.

Akram discloses in (col. 6, line 34 to col. 7, line 30 and figures 5-7) a method of fabricating a microelectric package comprising providing a substrate (figure 5, 10) having a first surface (figure 5, 18), an opposing second surface; forming a through-hole (figure 5, 60) extending from the substrate first surface to the substrate second surface; providing a microelectronic die (figure 5, 12) having an active surface (figure 5, 20), a back surface, and a plurality of pads (figure 5, 22) disposed on the active surface in a corresponding relationship to the plurality of substrate lands; electrically attaching the plurality of substrate lands to the plurality of corresponding microelectronic die pads with a plurality of conductive bumps (figure 5, 24); and disposing an underfill material (figure 5, 28) such that the underfill material is dispersed between the microelectronic die active surface and the substrate first surface wherein the underfill material is dispensed by a dispensing needle (figure 5, 34) and the underfill material comprises an epoxy material (col. 1, lines 46-58) and is cured (col. 7, lines 16-30). It would have been obvious to one of ordinary skill in the art at the time of the invention to combine the teachings of Akram with the method of AAPA in order to prevent the underfill material from spreading beyond the sidewalls of the semiconductor device (col. 3, lines 2-3).

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Neither AAPA nor Akram disclose positioning the microelectronic die and the substrate such that the microelectronic die is gravitationally below the substrate. However, Cha et al discloses that epoxy can be applied from the top down through a through hole instead of injected upward (figure 5B and col. 4, lines 5-20). It would have been obvious to one of ordinary skill at the time of the invention to combine the teachings of Cha with the combined method AAPA and Akram in order to provide a reduced

Conclusion

processing time and decreased solder fatigue (col. 2, lines 30-40).

Any inquiry concerning this communication or earlier communications from the examiner should be directed to Khiem D Nguyen whose telephone number is (703) 306-0210. The examiner can normally be reached on Monday-Friday (8:00 AM - 5:00 PM).

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Olik Chaudhuri can be reached on (703) 306-2794. The fax phone numbers for the organization where this application or proceeding is assigned are (703) 746-9179 for regular communications and (703) 746-9179 for After Final communications.

Any inquiry of a general nature or relating to the status of this application or proceeding should be directed to the receptionist whose telephone number is (703) 308-0956.

K.N. August 7, 2003 Olik Chardhuri Supervisory Patent Examiner Technology Center 2800

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